



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Shunpei Yamazaki et al. Art Unit : 2822
Serial No. : 10/730,047 Examiner : Roy Karl Potter
Filed : December 9, 2003 Confirmation No. 3013
Title : SEMICONDUCTOR CHIP AND METHOD FOR MANUFACTURING THE
SAME

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
ACC	JAPAN 10-125930 – English Abstract: DIALOG(R) File 347:JAPIO (2002); Accession No. 05842830
ADD	JAPAN 10-125931 – English Abstract: DIALOG(R) File 352:Derwent WPI (2002); Accession No. 011762805
AEE	JAPAN 2000-061785 – English Abstract: esp@cenet database: http://v3.espacenet.com/textdoc?DB=EPODOC&IDX=JP2000061785&F=8; 29 March 2005
AFF	JAPAN 2002-049359 – English Abstract: DIALOG(R) File 347:JAPIO (2004); Accession No. 07180968 & Concise Statement: This reference was cited in the specification of U.S. Patent Application Serial No. 10/774,700, filed on February 10, 2004, and describes, in a semiconductor device, a structure in which a substrate that becomes a panel includes both a pixel portion and a driving circuit that are integrally formed as an internal circuit and an external circuit that is formed outside of the panel.
AGG	JAPAN 3408154 – Full English Translation

Applicant : Shunpei Yamazaki et al.
Serial No. : 10/730,047
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Page : 2 of 2

Attorney's Docket No.: 12732-185001 / US6821

This statement is being filed before the receipt of a first Office Action on the merits.
Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: July 7, 2005

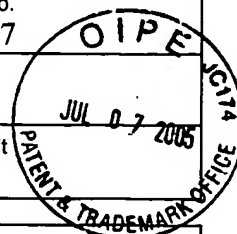


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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-185001	Application No. 10/730,047
	Applicant Shunpei Yamazaki et al.		
	Filing Date December 9, 2003	Group Art Unit 2822	



U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002/0131007 A1	09/19/2002	Yamazaki et al.			05/01/2002
	AB	2003/0025118 A1	02/06/2003	Yamazaki et al.			07/22/2002
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Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-185001	Application No. 10/730,047
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date December 9, 2003	Group Art Unit 2822

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	ABB	6,830,494 B1	12/14/2004	Yamazaki et al.			10/06/2000

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	ACC	10-125930	05/15/1998	JAPAN			AB	
	ADD	10-125931	05/15/1998	JAPAN			AB	
	AEE	2000-061785	02/29/2000	JAPAN			AB	
	AFF	2002-049359	02/15/2002	JAPAN			AB	
	AGG	3408154	05/19/2003	JAPAN			Full	

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AHH	"Mass Production of Organic EL Devices"; <i>Shimotsuke Newspaper</i> ; July 3, 2003 (full translation)
	AII	"Two-way display developed"; Newspaper " <i>The Japan Times</i> "; July 3, 2003
	AJJ	<i>Exhibition of Active Matrix Type Organic EL Display at "13th Flat Panel Display Manufacturing Technology Expo & Conference"</i> by ELDis Group; July 2, 2003 (full translation)
	AKK	Documents distributed in the " <i>13th Flat Panel Display Manufacturing Technology Expo & Conference</i> " by ELDis Group; July 3, 2003 (full translation)

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